APPLICATION INFORMATION

Application Type:: Regular

Subject Matter:: Utility

CD-ROM or CD-R?:: None

Title:: TEST CIRCUIT FOR MEASURING SENSE

AMPLIFIER AND MEMORY MISMATCHES

Attorney Docket Number:: 004-30059

Request for Early Publication?:: No

Request for Non-Publication?:: Yes

Suggested Drawing Figure:: 3

Total Drawing Sheets:: 5

Small Entity?:: No

Secrecy Order in Parent Appl.?:: No

APPLICANT INFORMATION

Applicant Authority Type:: Inventor

Primary Citizenship Country:: US

Status:: Full Capacity

Given Name:: Nadeem N.

Family Name:: Eleyan

Name Suffix::

City of Residence:: Austin

State or Province of Residence:: TX

Country of Residence:: US

Street:: 5604 Creek Meadows

City:: Austin

State or Province:: TX

Country:: US

Postal or ZIP Code:: 78731

Applicant Authority Type:: Inventor

Primary Citizenship Country:: US

Status:: Full Capacity

Given Name:: Howard L.

Family Name:: Levy

Name Suffix::

City of Residence:: Cedar Park

State or Province of Residence:: TX

Country of Residence:: US

Street:: 910 Brighton Bend Lane

City:: Cedar Park

State or Province:: TX

Country:: US

Postal or ZIP Code:: 78613

Applicant Authority Type:: Inventor

Primary Citizenship Country:: US

Status:: Full Capacity

Given Name:: Jeffrey Y.

Family Name:: Su

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Name Suffix::

City of Residence:: Cedar Park

State or Province of Residence:: TX

Country of Residence:: US

Street:: 1310 Whippoorwill Drive

City:: Cedar Park

State or Province:: TX

Country:: US

Postal or ZIP Code:: 78613

CORRESPONDENCE INFORMATION

Correspondence Customer Number:: 22120

DOMESTIC PRIORITY INFORMATION

Application:: Continuity Type:: Parent Application:: Parent Filing Date::

[Footer Information: 2 Initial 10/10/03]

This Application

Continuation of

FOREIGN PRIORITY INFORMATION

Country::

Application No::

Filing Date::

ASSIGNEE INFORMATION

Assignee name::

Sun Microsystems, Inc.